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SEAT No. :

**P599**

[Total No. of Pages : 2

[6004]-548

**B.E. (Electronics & Telecommunication Engg.)**

**VLSI DESIGN & TECHNOLOGY**

**(2019 Pattern) (Semester - VII) (404182)**

*Time : 2½ Hours]*

*[Max. Marks : 70*

*Instructions to the candidates:*

- 1) *Neat diagrams must be drawn wherever necessary.*
- 2) *Figures to the right indicate full marks.*
- 3) *Use of electronic pocket calculator is allowed.*
- 4) *Assume suitable data, if necessary.*

**Q1) a)** Compare CPLD and FPGA on the basis of features, specifications and applications. [6]

b) Explain in brief classification of PLDs. [6]

c) Explain various stages of Synthesis in FPGA with suitable diagram. [6]

OR

**Q2) a)** Draw and explain the architecture of FPGA. Explain CLB in detail. [10]

b) Explain Clock Management Techniques in FPGA. [8]

**Q3) a)** Design CMOS logic for  $Y = AB + CD$ . Calculate W/L ratio for NMOS and PMOS area needed on chip. Find the total area. [9]

b) Discuss need for transmission gate. Draw 4 : 1 Mux using TG. [8]

OR

**Q4) a)** Draw CMOS logic for 2 input NAND gate. Explain its working and draw its stick diagram. [9]

b) Explain the working of CMOS inverter with the help of Voltage Transfer curve. [8]

**Q5) a)** Draw and explain ASIC design flow. [6]

b) Discuss Lambda rules with diagram? (Any 6 rules) [6]

c) What is stick diagram? Draw Stick diagram of CMOS Inverter. [6]

OR

*P.T.O.*

**Q6)** Write short note on :

[18]

- a) Antenna Effect.
- b) Crosstalk.
- c) Electro migration.

**Q7)** a) Explain need of Design for Testability.

[8]

b) Explain Stack at Fault models in brief.

[9]

OR

**Q8)** a) Write short note on Built in Self-Test.

[8]

b) Write short note on Boundary Scan Method for testing.

[9]

